

Data Sheet January 2000 File Number 3962.2

## 6A, 1200V Ultrafast Diodes

The RURD6120 and RURD6120S are ultrafast diodes with soft recovery characteristics ( $t_{rr}$  < 70ns). They have low forward voltage drop and are silicon nitride passivated ionimplanted epitaxial planar construction.

These devices are intended for use as freewheeling/ clamping diodes and rectifiers in a variety of switching power supplies and other power switching applications. Their low stored charge and ultrafast soft recovery minimize ringing and electrical noise in many power switching circuits reducing power loss in the switching transistors.

Formerly development type TA49039.

#### Ordering Information

PART NUMBER	PACKAGE	BRAND		
RURD6120	TO-251	UR6120		
RURD6120S	TO-252	UR6120		

NOTE: When ordering, use the entire part number. Add the suffix 9A to obtain the TO-252 variant in the tape and reel, i.e., RURD6120S9A.

# Symbol

## Features

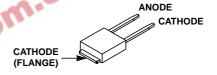
- · Avalanche Energy Rated
- Planar Construction

#### **Applications**

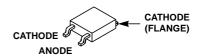
- · Switching Power Supplies
- · Power Switching Circuits
- General Purpose

## **Packaging**

JEDEC STYLE TO-251



#### JEDEC STYLE TO-252



**RURD6120** 

# **Absolute Maximum Ratings** $T_C = 25^{\circ}C$ , Unless Otherwise Specified

	RURD6120S	UNITS
Peak Repetitive Reverse VoltageV <sub>RRM</sub>	1200	V
Working Peak Reverse Voltage	1200	V
DC Blocking Voltage	1200	V
Average Rectified Forward Current $I_{F(AV)}$ ( $T_C = 140^{\circ}C$ )	6	Α
Repetitive Peak Surge Current	12	Α
Nonrepetitive Peak Surge Current	60	Α
Maximum Power Dissipation	50	W
Avalanche Energy (See Figures 10 and 11)	10	mJ
Operating and Storage Temperature	-65 to 175	oC
Maximum Lead Temperature for Soldering		
(Leads at 0.063 in. (1.6mm) from case for 10s)	300	oC
Package Body for 10s, see Tech Brief 334T <sub>PKG</sub>	260	oC

#### **RURD6120, RURD6120S**

#### **Electrical Specifications** $T_C = 25^{\circ}C$ , Unless Otherwise Specified

SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNITS
V <sub>F</sub>	I <sub>F</sub> = 6A	-	-	2.1	V
	$I_F = 6A, T_C = 150^{\circ}C$	-	-	1.9	V
I <sub>R</sub>	V <sub>R</sub> = 1200V	-	-	100	μА
	$V_R = 1200V, T_C = 150^{\circ}C$	-	-	500	μА
t <sub>rr</sub>	I <sub>F</sub> = 1A, dI <sub>F</sub> /dt = 200A/μs	-	-	70	ns
	I <sub>F</sub> = 6A, dI <sub>F</sub> /dt = 200A/μs	-	-	90	ns
ta	I <sub>F</sub> = 6A, dI <sub>F</sub> /dt = 200A/μs	-	45	-	ns
t <sub>b</sub>	I <sub>F</sub> = 6A, dI <sub>F</sub> /dt = 200A/μs	-	30	-	ns
Q <sub>RR</sub>	I <sub>F</sub> = 6A, dI <sub>F</sub> /dt = 200A/μs	-	400	-	nC
СЛ	V <sub>R</sub> = 10V, I <sub>F</sub> = 0A	-	22	-	pF
$R_{ heta JC}$		-	-	3	°C/W
$I_R$ = Instantaneous $t_{rr}$ = Reverse recov $t_a$ = Time to reach	forward voltage (pw = $300\mu s$ , D = $2\%$ ). Freverse current.  Very time (See Figure 9), summation of $t_a + t_b$ .  Peak reverse current (See Figure 9).  Reak $I_{RM}$ to projected zero crossing of $I_{RM}$ based on	a straight line from pe	eak I <sub>RM</sub> through 2	25% of I <sub>RM</sub> (See	Figure 9).
Q <sub>RR</sub> = Reverse recov	IXIVI I I	a chaight into from pe	KIM umouginz	-0 % % 1KM (000	i iguio oj.
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#### **DEFINITIONS**

C<sub>J</sub> = Junction Capacitance.

 $R_{\theta JC}$  = Thermal resistance junction to case.

pw = Pulse width.

D = Duty cycle.

## Typical Performance Curves

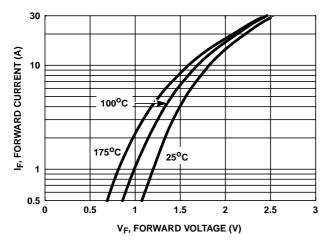


FIGURE 1. FORWARD CURRENT vs FORWARD VOLTAGE

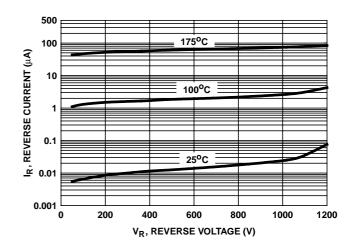


FIGURE 2. REVERSE CURRENT vs REVERSE VOLTAGE

## **RURD6120, RURD6120S**

## Typical Performance Curves (Continued)

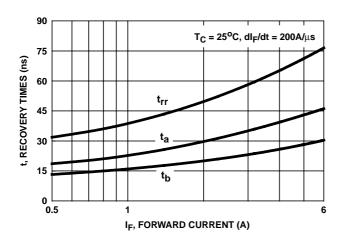


FIGURE 3.  $t_{rr}$ ,  $t_a$  AND  $t_b$  CURVES vs FORWARD CURRENT

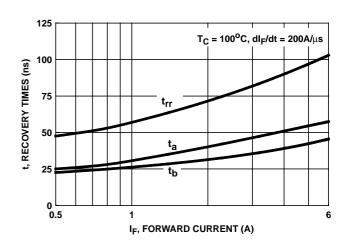


FIGURE 4.  $t_{rr}$ ,  $t_a$  AND  $t_b$  CURVES vs FORWARD CURRENT

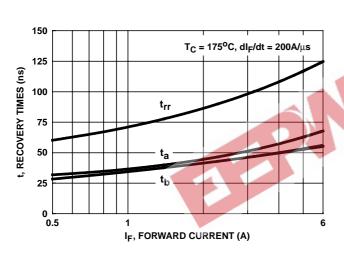


FIGURE 5.  $t_{rr}$ ,  $t_a$  and  $t_b$  curves vs forward current

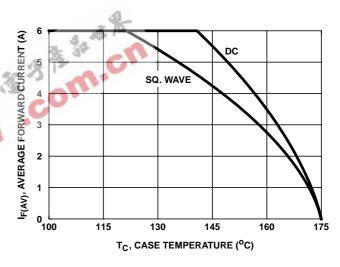


FIGURE 6. CURRENT DERATING CURVE

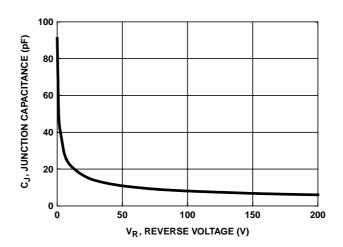


FIGURE 7. JUNCTION CAPACITANCE vs REVERSE VOLTAGE

#### **RURD6120, RURD6120S**

#### Test Circuits and Waveforms

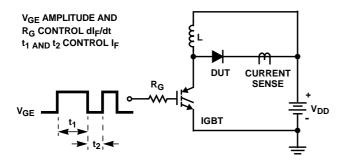


FIGURE 8. t<sub>rr</sub> TEST CIRCUIT

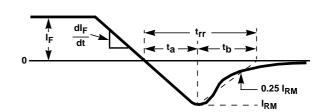


FIGURE 9. t<sub>rr</sub> WAVEFORMS AND DEFINITIONS

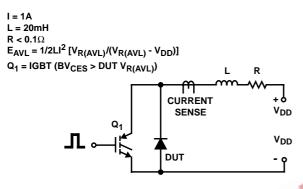


FIGURE 10. AVALANCHE ENERGY TEST CIRCUIT

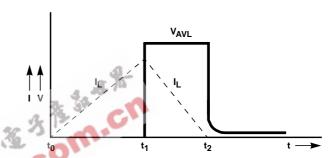


FIGURE 11. AVALANCHE CURRENT AND VOLTAGE WAVEFORMS

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